Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
09/839,695	BALABAN, NAOMI	
Examiner	Art Unit	
la-Na Hines	1645	

SEARCHED				
Class	Subclass	Date	Examiner	
424	9.34, 91.51, 93.42, 165.1 -	10/3/2005	JAH	
	184.1			
	185.1			
	190.1			
514	44			
530	388.2			
	388.21			
536	23.7			
			,	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC searched sequences, did interefence and inventor search. Commerical databases, west, medline, caplus, embase, biosis,	6/10/2005	JAH		
wpix, scisearch, eplus, japio, biotechno, agricola,	10/3/2005	JAH		
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